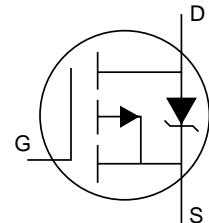


Description

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



Features

- V_{DS} (V) = -55V
- I_D = -74A (V_{GS} = -10V)
- $R_{DS(ON)} < 20m\Omega$ ($V_{GS} = -10V$)
- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free



Absolute Maximum Ratings

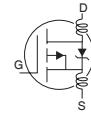
	Parameter	Max.	Units
I_D @ $T_C = 25^\circ C$	Continuous Drain Current, V_{GS} @ -10V	-74	A
I_D @ $T_C = 100^\circ C$	Continuous Drain Current, V_{GS} @ -10V	-52	
I_{DM}	Pulsed Drain Current ①	-260	
P_D @ $T_C = 25^\circ C$	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ②	930	mJ
I_{AR}	Avalanche Current ③	-38	A
E_{AR}	Repetitive Avalanche Energy ④	20	mJ
dv/dt	Peak Diode Recovery dv/dt ⑤	-5.0	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	0.75	0.75	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		
$R_{\theta JA}$	Junction-to-Ambient	62		

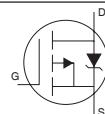
Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-55			V	$V_{\text{GS}} = 0\text{V}$, $I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient		-0.05		V°C	Reference to 25°C , $I_D = -1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance		20		$\text{m}\Omega$	$V_{\text{GS}} = -10\text{V}$, $I_D = -38\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = -250\mu\text{A}$
g_{fs}	Forward Transconductance	21			S	$V_{\text{DS}} = -25\text{V}$, $I_D = -38\text{A}$
I_{DSS}	Drain-to-Source Leakage Current			-25	μA	$V_{\text{DS}} = -55\text{V}$, $V_{\text{GS}} = 0\text{V}$
				-250		$V_{\text{DS}} = -44\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage		100		nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage		-100			$V_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge		180			$I_D = -38\text{A}$
Q_{gs}	Gate-to-Source Charge		32		nC	$V_{\text{DS}} = -44\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge		86			$V_{\text{GS}} = -10\text{V}$, See Fig. 6 and 13 ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	18				$V_{\text{DD}} = -28\text{V}$
t_r	Rise Time	99				$I_D = -38\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	61				$R_G = 2.5\Omega$
t_f	Fall Time	96				$R_D = 0.72\Omega$, See Fig. 10 ④
L_D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance		7.5			
C_{iss}	Input Capacitance		3400			$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance		1400		pF	$V_{\text{DS}} = -25\text{V}$
C_{rss}	Reverse Transfer Capacitance		640			$f = 1.0\text{MHz}$, See Fig. 5



Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)			-74	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①			-260		
V_{SD}	Diode Forward Voltage			-1.6	V	$T_J = 25^\circ\text{C}$, $I_S = -38\text{A}$, $V_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time		89	130	ns	$T_J = 25^\circ\text{C}$, $I_F = -38\text{A}$
Q_{rr}	Reverse Recovery Charge		230	350	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time					Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)



Notes:

① Repetitive rating; pulse width limited by max. junction temperature.

② Starting $T_J = 25^\circ\text{C}$, $L = 1.3\text{mH}$ $R_G = 25\Omega$, $I_{AS} = -38\text{A}$.

③ $I_{SD} \leq -38\text{A}$, $di/dt \leq -270\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$

④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

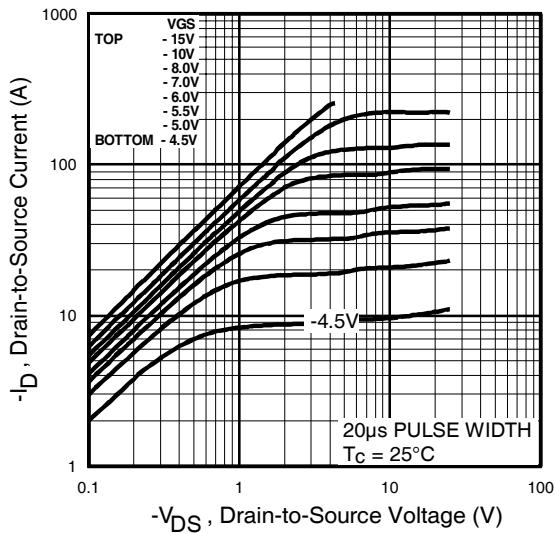


Fig 1. Typical Output Characteristics

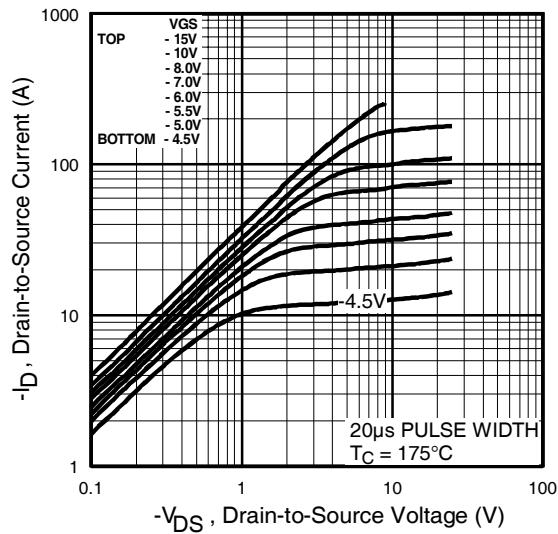


Fig 2. Typical Output Characteristics

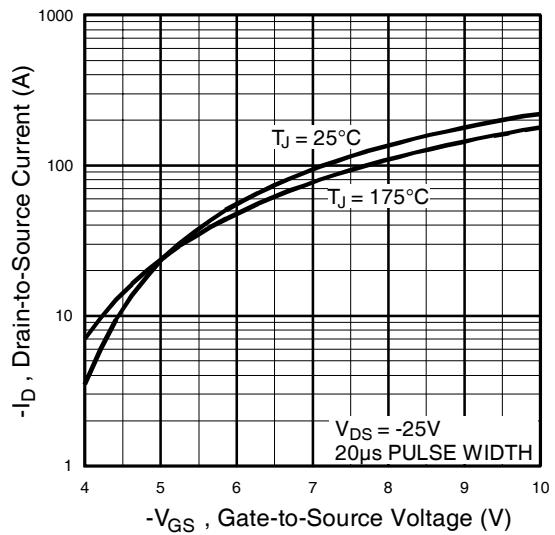


Fig 3. Typical Transfer Characteristics

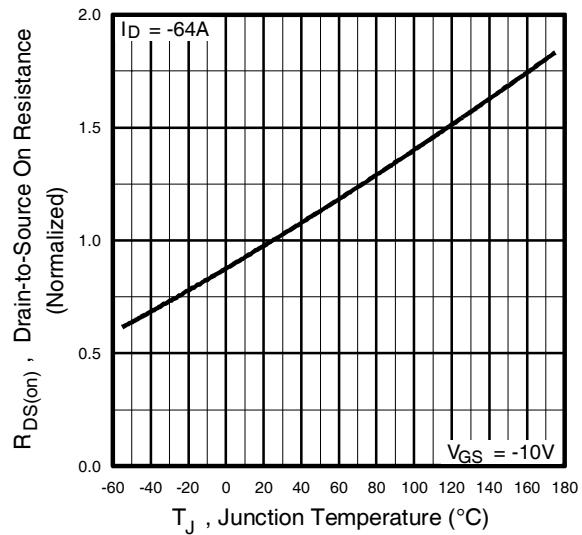


Fig 4. Normalized On-Resistance
Vs. Temperature

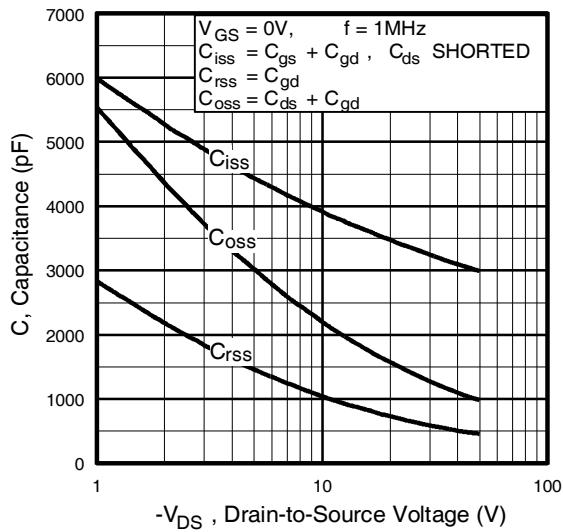


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

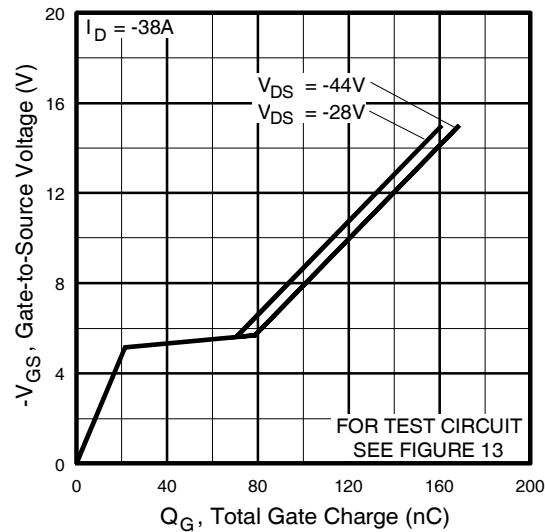


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

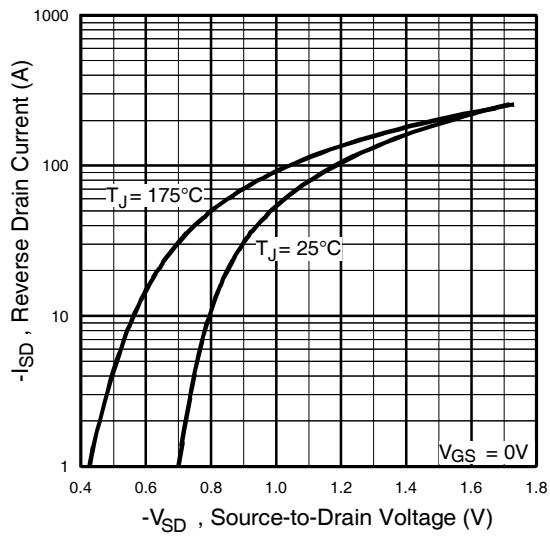


Fig 7. Typical Source-Drain Diode
Forward Voltage

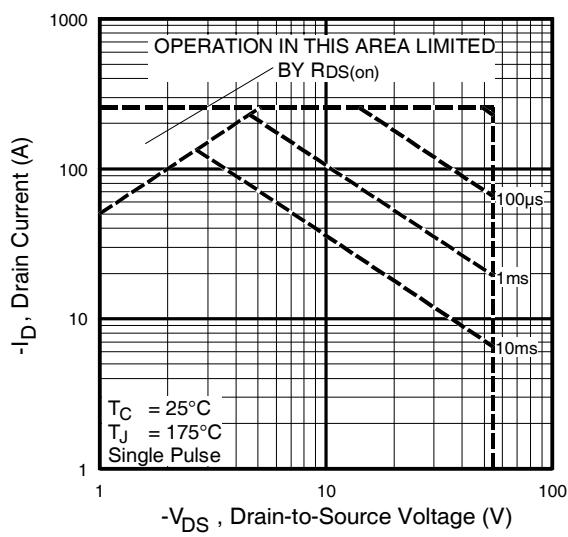


Fig 8. Maximum Safe Operating Area

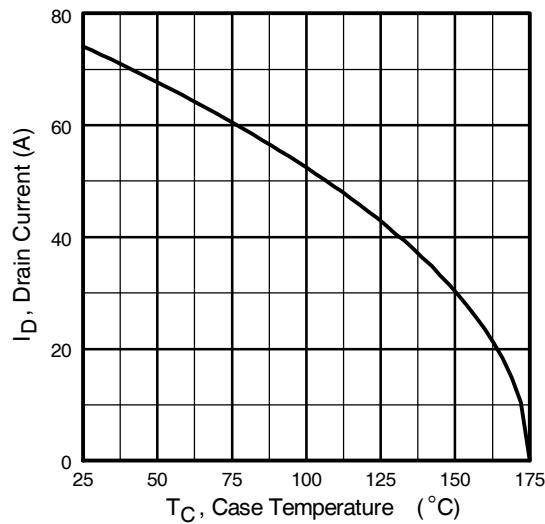


Fig 9. Maximum Drain Current Vs.
Case Temperature

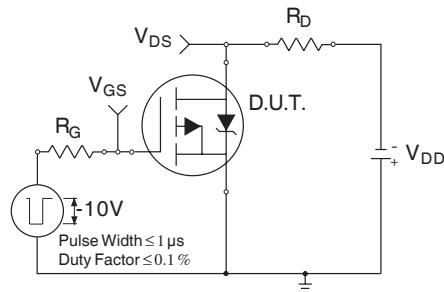


Fig 10a. Switching Time Test Circuit

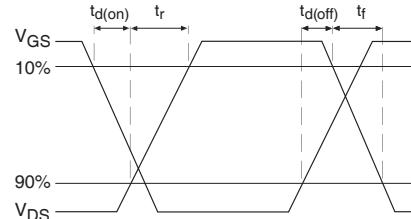


Fig 10b. Switching Time Waveforms

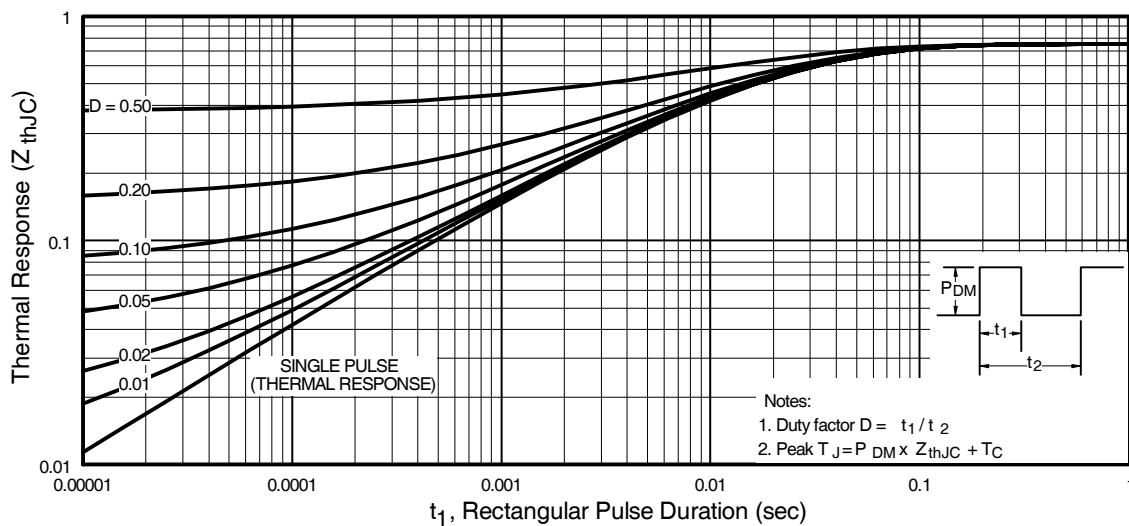


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

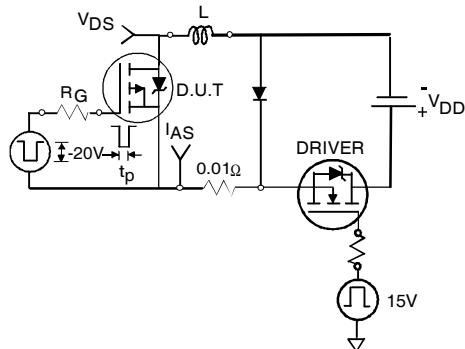


Fig 12a. Unclamped Inductive Test Circuit

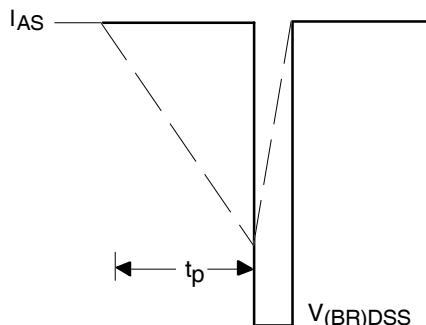


Fig 12b. Unclamped Inductive Waveforms

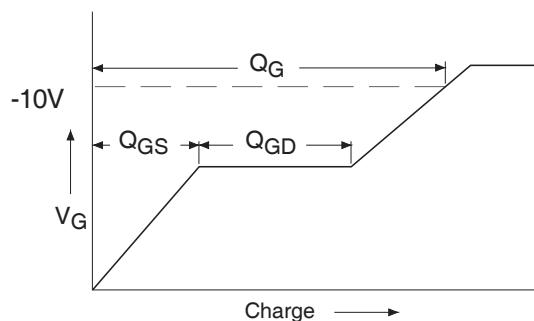


Fig 13a. Basic Gate Charge Waveform

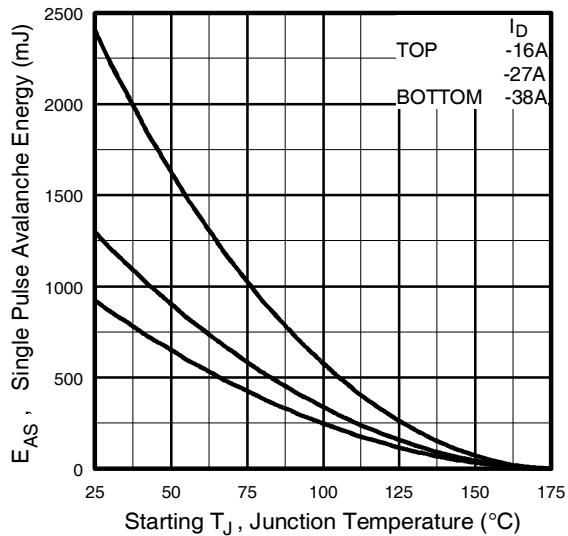


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

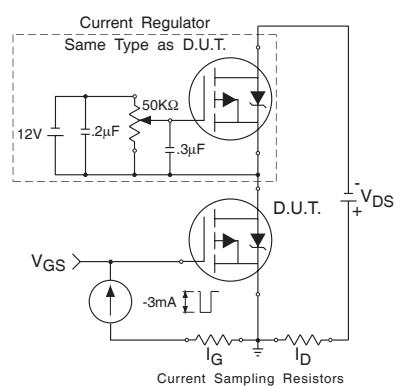
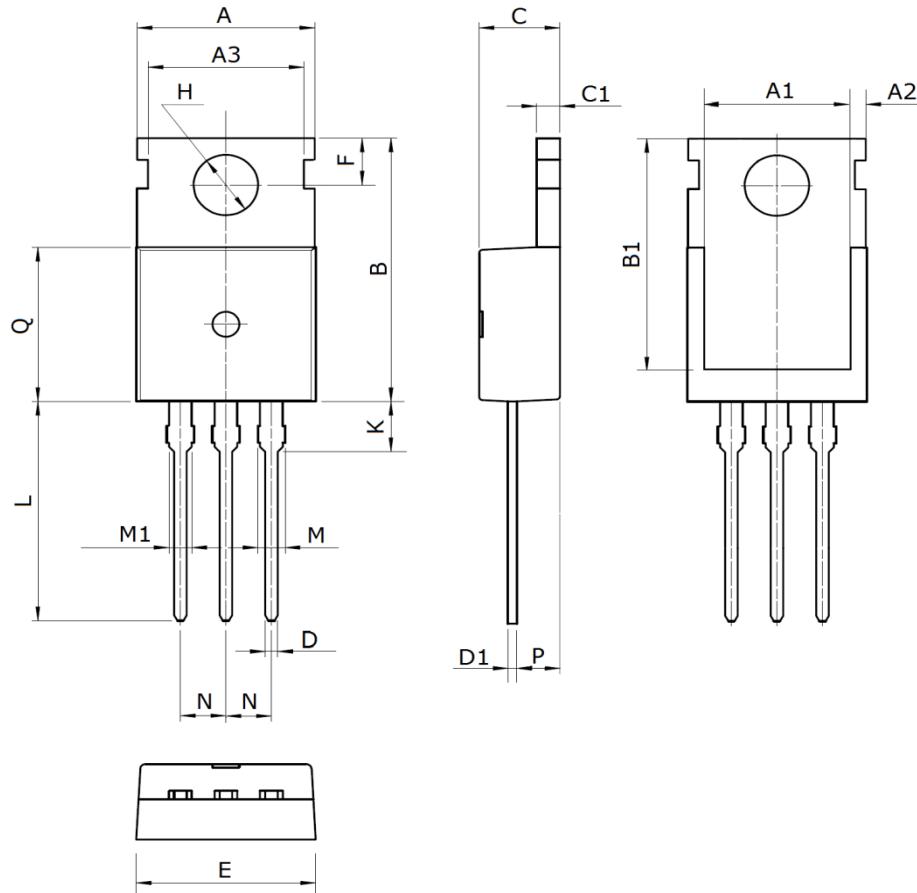
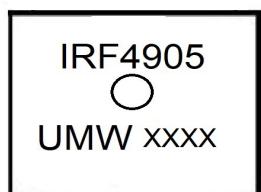


Fig 13b. Gate Charge Test Circuit

Package Mechanical Data TO-220



Symbol	Dimensions (mm)	Symbol	Dimensions (mm)	Symbol	Dimensions (mm)
A	10.0±0.3	C1	1.3±0.2	L	13.2±0.4
A1	8.0±0.2	D	0.8±0.2	M	1.38±0.1
A2	0.94±0.1	D1	0.5±0.1	M1	1.28±0.1
A3	8.7±0.1	E	10.0±0.3	N	2.54(typ)
B	15.6±0.4	F	2.8±0.1	P	2.4±0.3
B1	13.2±0.2	H	3.6±0.1	Q	9.15±0.25
C	4.5±0.2	K	3.1±0.2		

Marking**Ordering information**

Order code	Package	Baseqty	Deliverymode
UMW IRF4905	TO-220	1000	Tube and box